# imall

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## **OptiMOS<sup>®</sup>-T Power-Transistor**





#### Features

- N-channel Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green package (RoHS compliant)
- 100% Avalanche tested

#### **Product Summary**

V <sub>DS</sub>	40	V
R <sub>DS(on),max</sub>	3.6	mΩ
I <sub>D</sub>	90	А







Туре	Package	Marking		
IPD90N04S3-04	PG-TO252-3-11	QN0404		

#### Maximum ratings, at $T_j$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current <sup>1)</sup>	I <sub>D</sub>	T <sub>C</sub> =25°C, V <sub>GS</sub> =10V	90	А
		T <sub>C</sub> =100 °C, V <sub>GS</sub> =10 V <sup>2)</sup>	90	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	Т <sub>с</sub> =25 °С	360	
Avalanche energy, single pulse	E <sub>AS</sub>	/ <sub>D</sub> =90 A	260	mJ
Gate source voltage	V <sub>GS</sub>		±20	V
Power dissipation	P <sub>tot</sub>	7 <sub>с</sub> =25 °С	136	W
Operating and storage temperature	Τ <sub>j</sub> , Τ <sub>stg</sub>		-55 +175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	



Parameter	Symbol	Conditions		Values		Unit
			min.	typ.	max.	

## Thermal characteristics<sup>2)</sup>

Thermal resistance, junction - case	$R_{ m thJC}$		-	-	1.1	K/W
SMD version, device on PCB	$R_{\mathrm{thJA}}$	minimal footprint	-	-	62	
		6 cm <sup>2</sup> cooling area <sup>3)</sup>	-	-	40	

**Electrical characteristics,** at  $T_j$ =25 °C, unless otherwise specified

#### Static characteristics

Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0 V, <i>I</i> <sub>D</sub> = 1 mA	40	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V <sub>DS</sub> =V <sub>GS</sub> , / <sub>D</sub> =90 μA	2.1	3.0	4.0	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =40 V, V <sub>GS</sub> =0 V, 7 <sub>j</sub> =25 °C	-	-	1	μA
		V <sub>DS</sub> =40 V, V <sub>GS</sub> =0 V, T <sub>j</sub> =125 °C <sup>2)</sup>	-	-	100	
Gate-source leakage current	I <sub>GSS</sub>	$V_{\rm GS}$ =20 V, $V_{\rm DS}$ =0 V	-	-	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10 V, / <sub>D</sub> =80 A	-	2.9	3.6	mΩ



Parameter	Symbol	Symbol Conditions		Values		
			min.	typ.	max.	
Dynamic characteristics <sup>2)</sup>						
Input capacitance	C <sub>iss</sub>		-	4000	5200	pF
Output capacitance	Coss	V <sub>GS</sub> =0 V, V <sub>DS</sub> =25 V, f=1 MHz	-	1100	1400	1
Reverse transfer capacitance	C <sub>rss</sub>		-	170	250	
Turn-on delay time	t <sub>d(on)</sub>		-	20	-	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =20 V, V <sub>GS</sub> =10 V,	-	13	-	
Turn-off delay time	t <sub>d(off)</sub>	/ <sub>D</sub> =90 A, R <sub>G</sub> =3.5 Ω	-	30	-	
Fall time	t <sub>f</sub>		-	10	-	
Gate Charge Characteristics <sup>2)</sup>				1		T
Gate to source charge	Q <sub>gs</sub>		-	23	30	nC
Gate to drain charge	$Q_{gd}$	V <sub>DD</sub> =32 V, <i>I</i> <sub>D</sub> =90 A,	-	15	26	
Gate charge total	Qg	V <sub>GS</sub> =0 to 10 V	-	60	80	
Gate plateau voltage	$V_{\sf plateau}$		-	5.6	-	V
Reverse Diode						
Diode continous forward current <sup>2)</sup>	I <sub>S</sub>		-	-	90	А
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	• <i>T</i> <sub>C</sub> =25 °C	-	-	360	1
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0 V, <i>I</i> <sub>F</sub> =90 A, <i>T</i> <sub>j</sub> =25 °C	-	0.95	1.3	v
Reverse recovery time <sup>2)</sup>	t <sub>rr</sub>	V <sub>R</sub> =20 V, / <sub>F</sub> =/ <sub>S</sub> , d <i>i</i> <sub>F</sub> /d <i>t</i> =100 A/µs	-	35	-	ns
Reverse recovery charge <sup>2)</sup>	Q <sub>rr</sub>		-	35	-	nC

<sup>1)</sup> Current is limited by bondwire; with an  $R_{\text{thJC}}$  = 1.1K/W the chip is able to carry 144A at 25°C. For detailed information see Application Note ANPS071E at *www.infineon.com/optimos* 

<sup>2)</sup> Defined by design. Not subject to production test.

 $^{3)}$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.



## infineon

#### 1 Power dissipation

$$P_{tot} = f(T_C); V_{GS} \ge 6 V$$

#### 2 Drain current

 $I_{\rm D}={\rm f}(T_{\rm C});\;V_{\rm GS}\geq 6\;{\rm V}$ 





#### 3 Safe operating area

 $I_{\rm D} = f(V_{\rm DS}); T_{\rm C} = 25 \text{ °C}; D = 0$ 

parameter: t<sub>p</sub>



#### 4 Max. transient thermal impedance

$$Z_{\rm thJC} = f(t_{\rm p})$$

parameter:  $D = t_p/T$ 







#### 5 Typ. output characteristics

### $I_{\rm D} = f(V_{\rm DS}); T_{\rm j} = 25 \,^{\circ}{\rm C}$

parameter: V<sub>GS</sub>

/<sub>b</sub> [A]



#### 7 Typ. transfer characteristics

 $I_{\rm D} = f(V_{\rm GS}); V_{\rm DS} = 6V$ 

parameter: T<sub>j</sub>



#### 6 Typ. drain-source on-state resistance

8 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j); I_D = 80 \text{ A}; V_{GS} = 10 \text{ V}$ 

 $R_{DS(on)} = f(I_D); T_j = 25 \text{ °C}$ 

parameter:  $V_{\rm GS}$ 



#### 9 Typ. gate threshold voltage

 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$ 

parameter:  $I_{\rm D}$ 



#### 11 Typical forward diode characteristicis

 $IF = f(V_{SD})$ 

parameter: T<sub>j</sub>



#### 10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$ 



#### 12 Typ. avalanche characteristics

 $I_{AS} = f(t_{AV})$ 

parameter:  $T_{j(start)}$ 





14 Typ. drain-source breakdown voltage

 $V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$ 

16 Gate charge waveforms

#### 13 Typical avalanche energy

### $E_{AS} = f(T_j)$

parameter: I D



#### 15 Typ. gate charge

 $V_{\rm GS}$  = f( $Q_{\rm gate}$ );  $I_{\rm D}$  = 90 A pulsed









Published by Infineon Technologies AG 81726 Munich, Germany

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## Revision History

Version	Date	Changes